

Welcome to [E-XFL.COM](#)

### What is "[Embedded - Microcontrollers](#)"?

"[Embedded - Microcontrollers](#)" refer to small, integrated circuits designed to perform specific tasks within larger systems. These microcontrollers are essentially compact computers on a single chip, containing a processor core, memory, and programmable input/output peripherals. They are called "embedded" because they are embedded within electronic devices to control various functions, rather than serving as standalone computers. Microcontrollers are crucial in modern electronics, providing the intelligence and control needed for a wide range of applications.

### Applications of "[Embedded - Microcontrollers](#)"

#### Details

Product Status	Active
Core Processor	ARM® Cortex®-M4
Core Size	32-Bit Single-Core
Speed	168MHz
Connectivity	CANbus, DCMI, EBI/EMI, Ethernet, I <sup>2</sup> C, IrDA, LINbus, SPI, UART/USART, USB OTG
Peripherals	Brown-out Detect/Reset, DMA, I <sup>2</sup> S, LCD, POR, PWM, WDT
Number of I/O	140
Program Memory Size	512KB (512K x 8)
Program Memory Type	FLASH
EEPROM Size	-
RAM Size	192K x 8
Voltage - Supply (Vcc/Vdd)	1.8V ~ 3.6V
Data Converters	A/D 24x12b; D/A 2x12b
Oscillator Type	Internal
Operating Temperature	-40°C ~ 85°C (TA)
Mounting Type	Surface Mount
Package / Case	201-UFPGA
Supplier Device Package	176+25UFPGA (10x10)
Purchase URL	<a href="https://www.e-xfl.com/product-detail/stmicroelectronics/stm32f407ieh6tr">https://www.e-xfl.com/product-detail/stmicroelectronics/stm32f407ieh6tr</a>

	recommended footprint. . . . .	175
Figure 86.	LQFP144 marking example (package top view) . . . . .	176
Figure 87.	UFBGA176+25 ball, 10 x 10 mm, 0.65 mm pitch, ultra fine pitch ball grid array package outline . . . . .	177
Figure 88.	UFBGA176+25 - 201-ball, 10 x 10 mm, 0.65 mm pitch, ultra fine pitch ball grid array recommended footprint. . . . .	178
Figure 89.	UFBGA176+25 marking example (package top view) . . . . .	179
Figure 90.	LQFP176 - 176-pin, 24 x 24 mm low profile quad flat package outline . . . . .	180
Figure 91.	LQFP176 - 176-pin, 24 x 24 mm low profile quad flat recommended footprint. . . . .	182
Figure 92.	LQFP176 marking example (package top view) . . . . .	183
Figure 93.	USB controller configured as peripheral-only and used in Full speed mode . . . . .	186
Figure 94.	USB controller configured as host-only and used in full speed mode. . . . .	186
Figure 95.	USB controller configured in dual mode and used in full speed mode . . . . .	187
Figure 96.	USB controller configured as peripheral, host, or dual-mode and used in high speed mode. . . . .	188
Figure 97.	MII mode using a 25 MHz crystal . . . . .	189
Figure 98.	RMII with a 50 MHz oscillator . . . . .	189
Figure 99.	RMII with a 25 MHz crystal and PHY with PLL. . . . .	190

# 1 Introduction

This datasheet provides the description of the STM32F405xx and STM32F407xx lines of microcontrollers. For more details on the whole STMicroelectronics STM32™ family, please refer to [Section 2.1: Full compatibility throughout the family](#).

The STM32F405xx and STM32F407xx datasheet should be read in conjunction with the STM32F4xx reference manual which is available from the STMicroelectronics website [www.st.com](http://www.st.com).

For information on the Cortex®-M4 core, please refer to the Cortex®-M4 programming manual (PM0214) available from [www.st.com](http://www.st.com).

Table 8. FSMC pin definition (continued)

Pins <sup>(1)</sup>	FSMC				LQFP100 <sup>(2)</sup>	WLCSP90 <sup>(2)</sup>
	CF	NOR/PSRAM/ SRAM	NOR/PSRAM Mux	NAND 16 bit		
PG2	-	A12	-	-	-	-
PG3	-	A13	-	-	-	-
PG4	-	A14	-	-	-	-
PG5	-	A15	-	-	-	-
PG6	-	-	-	INT2	-	-
PG7	-	-	-	INT3	-	-
PD0	D2	D2	DA2	D2	Yes	Yes
PD1	D3	D3	DA3	D3	Yes	Yes
PD3	-	CLK	CLK	-	Yes	-
PD4	NOE	NOE	NOE	NOE	Yes	Yes
PD5	NWE	NWE	NWE	NWE	Yes	Yes
PD6	NWAIT	NWAIT	NWAIT	NWAIT	Yes	Yes
PD7	-	NE1	NE1	NCE2	Yes	Yes
PG9	-	NE2	NE2	NCE3	-	-
PG10	NCE4_1	NE3	NE3	-	-	-
PG11	NCE4_2	-	-	-	-	-
PG12	-	NE4	NE4	-	-	-
PG13	-	A24	A24	-	-	-
PG14	-	A25	A25	-	-	-
PB7	-	NADV	NADV	-	Yes	Yes
PE0	-	NBL0	NBL0	-	Yes	-
PE1	-	NBL1	NBL1	-	Yes	-

1. Full FSMC features are available on LQFP144, LQFP176, and UFBGA176. The features available on smaller packages are given in the dedicated package column.

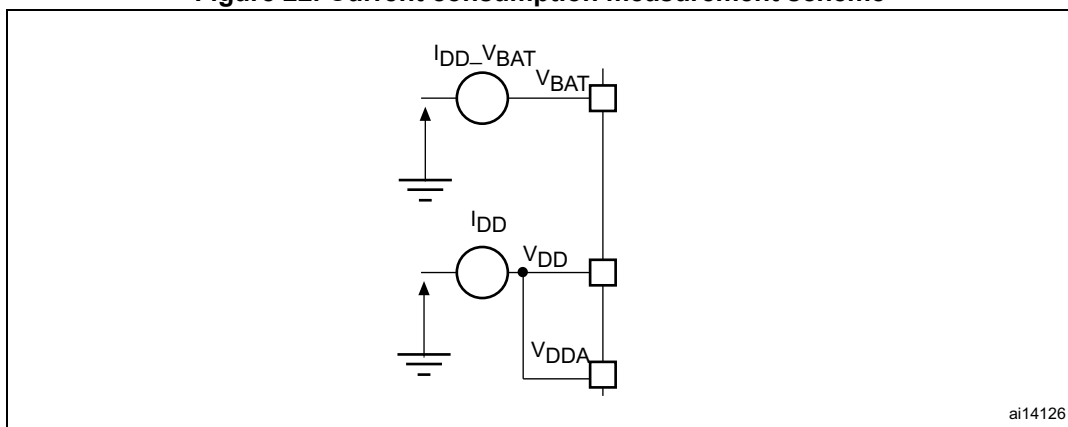
2. Ports F and G are not available in devices delivered in 100-pin packages.

**Table 9. Alternate function mapping**

Port		AF0	AF1	AF2	AF3	AF4	AF5	AF6	AF7	AF8	AF9	AF10	AF11	AF12	AF13	AF14	AF15
		SYS	TIM1/2	TIM3/4/5	TIM8/9/10 /11	I2C1/2/3	SPI1/SPI2/ I2S2/I2S2e xt	SPI3/I2Sext /I2S3	USART1/2/3/ I2S3ext	UART4/5/ USART6	CAN1/2 TIM12/13/ 14	OTG_FS/ OTG_HS	ETH	FSMC/SDIO /OTG_FS	DCMI		
Port A	PA0	-	TIM2_CH1_ ETR	TIM5_CH1	TIM8_ETR	-	-	-	USART2_CTS	UART4_TX	-	-	ETH_MII_CRS	-	-	-	EVENTOUT
	PA1	-	TIM2_CH2	TIM5_CH2	-	-	-	-	USART2_RTS	UART4_RX	-	-	ETH_MII _RX_CLK ETH_RMII_REF _CLK	-	-	-	EVENTOUT
	PA2	-	TIM2_CH3	TIM5_CH3	TIM9_CH1	-	-	-	USART2_TX	-	-	-	ETH_MDIO	-	-	-	EVENTOUT
	PA3	-	TIM2_CH4	TIM5_CH4	TIM9_CH2	-	-	-	USART2_RX	-	-	OTG_HS_ULPI_ D0	ETH_MII_COL	-	-	-	EVENTOUT
	PA4	-	-	-	-	-	SPI1_NSS	SPI3_NSS I2S3_WS	USART2_CK	-	-	-	-	OTG_HS_SOF	DCMI_ HSYNC	-	EVENTOUT
	PA5	-	TIM2_CH1_ ETR	-	TIM8_CH1N	-	SPI1_SCK	-	-	-	-	OTG_HS_ULPI_ CK	-	-	-	-	EVENTOUT
	PA6	-	TIM1_BKIN	TIM3_CH1	TIM8_BKIN	-	SPI1_MISO	-	-	-	TIM13_CH1	-	-	-	DCMI_PIXCK	-	EVENTOUT
	PA7	-	TIM1_CH1N	TIM3_CH2	TIM8_CH1N	-	SPI1_MOSI	-	-	-	TIM14_CH1	-	ETH_MII_RX_DV ETH_RMII _CRS_DV	-	-	-	EVENTOUT
	PA8	MCO1	TIM1_CH1	-	-	I2C3_SCL	-	-	USART1_CK	-	-	OTG_FS_SOF	-	-	-	-	EVENTOUT
	PA9	-	TIM1_CH2	-	-	I2C3_ SMBA	-	-	USART1_TX	-	-	-	-	-	DCMI_D0	-	EVENTOUT
	PA10	-	TIM1_CH3	-	-	-	-	-	USART1_RX	-	-	OTG_FS_ID	-	-	DCMI_D1	-	EVENTOUT
	PA11	-	TIM1_CH4	-	-	-	-	-	USART1_CTS	-	CAN1_RX	OTG_FS_DM	-	-	-	-	EVENTOUT
	PA12	-	TIM1_ETR	-	-	-	-	-	USART1_RTS	-	CAN1_TX	OTG_FS_DP	-	-	-	-	EVENTOUT
	PA13	JTMS- SWDIO	-	-	-	-	-	-	-	-	-	-	-	-	-	-	EVENTOUT
	PA14	JTCK- SWCLK	-	-	-	-	-	-	-	-	-	-	-	-	-	-	EVENTOUT
	PA15	JTDI	TIM2_CH1 TIM2_ETR	-	-	-	SPI1_NSS	SPI3_NSS/ I2S3_WS	-	-	-	-	-	-	-	-	EVENTOUT

### 5.1.7 Current consumption measurement

Figure 22. Current consumption measurement scheme



## 5.2 Absolute maximum ratings

Stresses above the absolute maximum ratings listed in [Table 11: Voltage characteristics](#), [Table 12: Current characteristics](#), and [Table 13: Thermal characteristics](#) may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these conditions is not implied. Exposure to maximum rating conditions for extended periods may affect device reliability. Device mission profile (application conditions) is compliant with JEDEC JESD47 Qualification Standard, extended mission profiles are available on demand.

Table 11. Voltage characteristics

Symbol	Ratings	Min	Max	Unit
$V_{DD}-V_{SS}$	External main supply voltage (including $V_{DDA}$ , $V_{DD}$ ) <sup>(1)</sup>	-0.3	4.0	V
$V_{IN}$	Input voltage on five-volt tolerant pin <sup>(2)</sup>	$V_{SS}-0.3$	$V_{DD}+4$	
	Input voltage on any other pin	$V_{SS}-0.3$	4.0	
$ \Delta V_{DDx} $	Variations between different $V_{DD}$ power pins	-	50	mV
$ V_{SSx}-V_{SS} $	Variations between all the different ground pins including $V_{REF-}$	-	50	
$V_{ESD(HBM)}$	Electrostatic discharge voltage (human body model)	see <a href="#">Section 5.3.14: Absolute maximum ratings (electrical sensitivity)</a>		

1. All main power ( $V_{DD}$ ,  $V_{DDA}$ ) and ground ( $V_{SS}$ ,  $V_{SSA}$ ) pins must always be connected to the external power supply, in the permitted range.
2.  $V_{IN}$  maximum value must always be respected. Refer to [Table 12](#) for the values of the maximum allowed injected current.

Table 19. Embedded reset and power control block characteristics (continued)

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
$V_{BOR2}$	Brownout level 2 threshold	Falling edge	2.44	2.50	2.56	V
		Rising edge	2.53	2.59	2.63	V
$V_{BOR3}$	Brownout level 3 threshold	Falling edge	2.75	2.83	2.88	V
		Rising edge	2.85	2.92	2.97	V
$V_{BORhyst}^{(1)}$	BOR hysteresis	-	-	100	-	mV
$T_{RSTTEMPO}^{(1)(2)}$	Reset temporization	-	0.5	1.5	3.0	ms
$I_{RUSH}^{(1)}$	InRush current on voltage regulator power-on (POR or wakeup from Standby)	-	-	160	200	mA
$E_{RUSH}^{(1)}$	InRush energy on voltage regulator power-on (POR or wakeup from Standby)	$V_{DD} = 1.8\text{ V}$ , $T_A = 105\text{ }^{\circ}\text{C}$ , $I_{RUSH} = 171\text{ mA}$ for $31\text{ }\mu\text{s}$	-	-	5.4	$\mu\text{C}$

1. Guaranteed by design.

2. The reset temporization is measured from the power-on (POR reset or wakeup from  $V_{BAT}$ ) to the instant when first instruction is read by the user application code.

### 5.3.6 Supply current characteristics

The current consumption is a function of several parameters and factors such as the operating voltage, ambient temperature, I/O pin loading, device software configuration, operating frequencies, I/O pin switching rate, program location in memory and executed binary code.

The current consumption is measured as described in [Figure 22: Current consumption measurement scheme](#).

All Run mode current consumption measurements given in this section are performed using a CoreMark-compliant code.

#### Typical and maximum current consumption

The MCU is placed under the following conditions:

- At startup, all I/O pins are configured as analog inputs by firmware.
- All peripherals are disabled except if it is explicitly mentioned.
- The Flash memory access time is adjusted to  $f_{HCLK}$  frequency (0 wait state from 0 to 30 MHz, 1 wait state from 30 to 60 MHz, 2 wait states from 60 to 90 MHz, 3 wait states from 90 to 120 MHz, 4 wait states from 120 to 150 MHz, and 5 wait states from 150 to 168 MHz).
- When the peripherals are enabled HCLK is the system clock,  $f_{PCLK1} = f_{HCLK}/4$ , and  $f_{PCLK2} = f_{HCLK}/2$ , except is explicitly mentioned.
- The maximum values are obtained for  $V_{DD} = 3.6\text{ V}$  and maximum ambient temperature ( $T_A$ ), and the typical values for  $T_A = 25\text{ }^{\circ}\text{C}$  and  $V_{DD} = 3.3\text{ V}$  unless otherwise specified.

Table 22. Typical and maximum current consumption in Sleep mode

Symbol	Parameter	Conditions	f <sub>HCLK</sub>	Typ	Max <sup>(1)</sup>		Unit
				T <sub>A</sub> = 25 °C	T <sub>A</sub> = 85 °C	T <sub>A</sub> = 105 °C	
I <sub>DD</sub>	Supply current in Sleep mode	External clock <sup>(2)</sup> , all peripherals enabled <sup>(3)</sup>	168 MHz	59	77	84	mA
			144 MHz	46	61	67	
			120 MHz	38	53	60	
			90 MHz	30	44	51	
			60 MHz	20	34	41	
			30 MHz	11	24	31	
			25 MHz	8	21	28	
			16 MHz	6	18	25	
			8 MHz	3	16	23	
			4 MHz	2	15	22	
			2 MHz	2	14	21	
		External clock <sup>(2)</sup> , all peripherals disabled	168 MHz	12	27	35	
			144 MHz	9	22	29	
			120 MHz	8	20	28	
			90 MHz	7	19	26	
			60 MHz	5	17	24	
			30 MHz	3	16	23	
			25 MHz	2	15	22	
			16 MHz	2	14	21	
			8 MHz	1	14	21	
			4 MHz	1	13	21	
			2 MHz	1	13	21	

1. Guaranteed by characterization, tested in production at V<sub>DD</sub> max and f<sub>HCLK</sub> max with peripherals enabled.

2. External clock is 4 MHz and PLL is on when f<sub>HCLK</sub> > 25 MHz.

3. Add an additional power consumption of 1.6 mA per ADC for the analog part. In applications, this consumption occurs only while the ADC is ON (ADON bit is set in the ADC\_CR2 register).



### 5.3.18 TIM timer characteristics

The parameters given in [Table 52](#) and [Table 53](#) are guaranteed by design.

Refer to [Section 5.3.16: I/O port characteristics](#) for details on the input/output alternate function characteristics (output compare, input capture, external clock, PWM output).

**Table 52. Characteristics of TIMx connected to the APB1 domain<sup>(1)</sup>**

Symbol	Parameter	Conditions	Min	Max	Unit
$t_{res(TIM)}$	Timer resolution time	AHB/APB1 prescaler distinct from 1, $f_{TIMxCLK} = 84\text{ MHz}$	1	-	$t_{TIMxCLK}$
			11.9	-	ns
		AHB/APB1 prescaler = 1, $f_{TIMxCLK} = 42\text{ MHz}$	1	-	$t_{TIMxCLK}$
			23.8	-	ns
$f_{EXT}$	Timer external clock frequency on CH1 to CH4	$f_{TIMxCLK} = 84\text{ MHz}$ APB1= 42 MHz	0	$f_{TIMxCLK}/2$	MHz
	0		42	MHz	
$Res_{TIM}$	Timer resolution		-	16/32	bit
$t_{COUNTER}$	16-bit counter clock period when internal clock is selected		1	65536	$t_{TIMxCLK}$
	32-bit counter clock period when internal clock is selected		0.0119	780	$\mu s$
			1	-	$t_{TIMxCLK}$
			0.0119	51130563	$\mu s$
$t_{MAX\_COUNT}$	Maximum possible count		-	$65536 \times 65536$	$t_{TIMxCLK}$
			-	51.1	s

1. TIMx is used as a general term to refer to the TIM2, TIM3, TIM4, TIM5, TIM6, TIM7, and TIM12 timers.

Table 61. USB HS clock timing parameters<sup>(1)</sup>

Parameter		Symbol	Min	Nominal	Max	Unit
Frequency (steady state) $\pm 500$ ppm		$F_{\text{STEADY}}$	59.97	60	60.03	MHz
Duty cycle (first transition)	8-bit $\pm 10\%$	$D_{\text{START\_8BIT}}$	40	50	60	%
Duty cycle (steady state) $\pm 500$ ppm		$D_{\text{STEADY}}$	49.975	50	50.025	%
Time to reach the steady state frequency and duty cycle after the first transition		$T_{\text{STEADY}}$	-	-	1.4	ms
Clock startup time after the de-assertion of SuspendM	Peripheral	$T_{\text{START\_DEV}}$	-	-	5.6	ms
	Host	$T_{\text{START\_HOST}}$	-	-	-	
PHY preparation time after the first transition of the input clock		$T_{\text{PREP}}$	-	-	-	$\mu\text{s}$

1. Guaranteed by design.

Table 62. ULPI timing

Parameter	Symbol	Value <sup>(1)</sup>		Unit
		Min.	Max.	
Control in (ULPI_DIR) setup time	$t_{\text{SC}}$	-	2.0	ns
Control in (ULPI_NXT) setup time		-	1.5	
Control in (ULPI_DIR, ULPI_NXT) hold time	$t_{\text{HC}}$	0	-	
Data in setup time	$t_{\text{SD}}$	-	2.0	
Data in hold time	$t_{\text{HD}}$	0	-	
Control out (ULPI_STP) setup time and hold time	$t_{\text{DC}}$	-	9.2	
Data out available from clock rising edge	$t_{\text{DD}}$	-	10.7	

1.  $V_{\text{DD}} = 2.7 \text{ V}$  to  $3.6 \text{ V}$  and  $T_{\text{A}} = -40$  to  $85 \text{ }^{\circ}\text{C}$ .

Figure 45. ULPI timing diagram

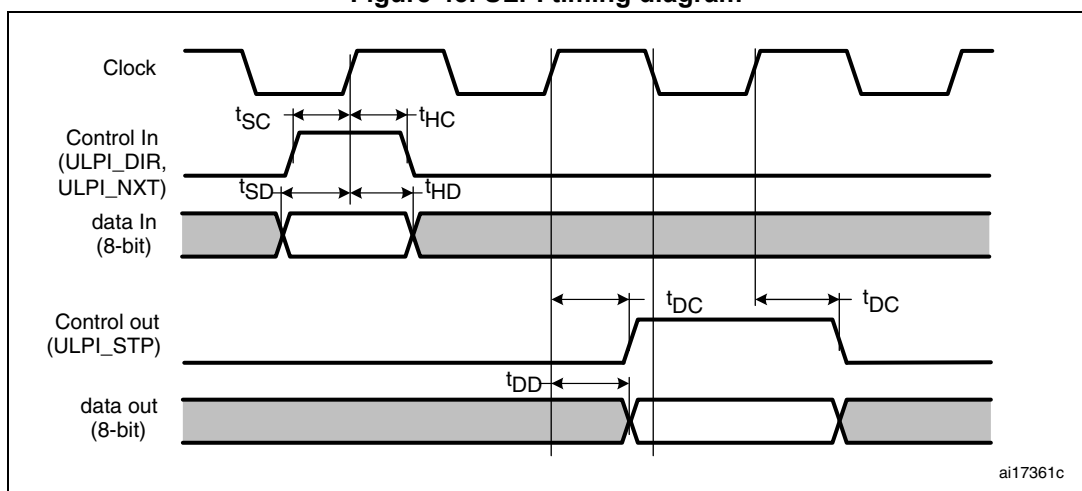


Table 66. Dynamic characteristics: Ethernet MAC signals for MII<sup>(1)</sup>

Symbol	Parameter	Min	Typ	Max	Unit
$t_{su(RXD)}$	Receive data setup time	9		-	ns
$t_{ih(RXD)}$	Receive data hold time	10		-	
$t_{su(DV)}$	Data valid setup time	9		-	
$t_{ih(DV)}$	Data valid hold time	8		-	
$t_{su(ER)}$	Error setup time	6		-	
$t_{ih(ER)}$	Error hold time	8		-	
$t_d(TXEN)$	Transmit enable valid delay time	0	10	14	
$t_d(TXD)$	Transmit data valid delay time	0	10	15	

1. Guaranteed by characterization.

### 5.3.20 CAN (controller area network) interface

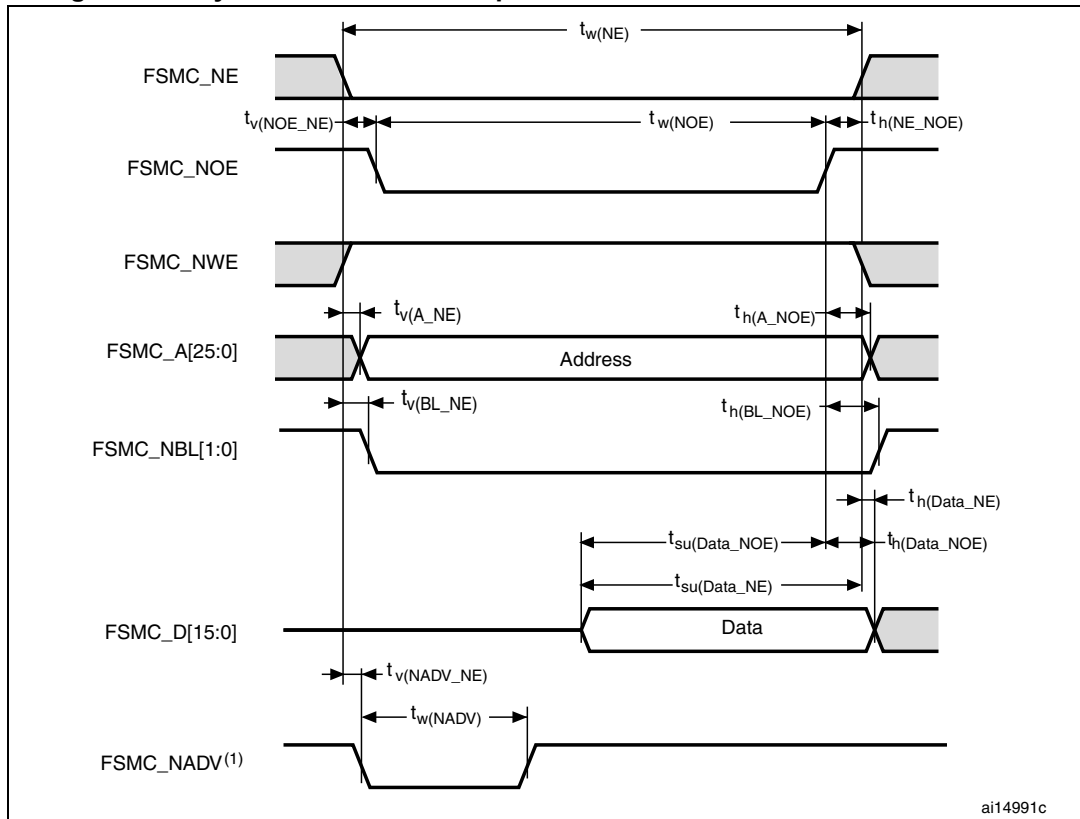
Refer to [Section 5.3.16: I/O port characteristics](#) for more details on the input/output alternate function characteristics (CANTX and CANRX).

### 5.3.21 12-bit ADC characteristics

Unless otherwise specified, the parameters given in [Table 67](#) are derived from tests performed under the ambient temperature,  $f_{PCLK2}$  frequency and  $V_{DDA}$  supply voltage conditions summarized in [Table 14](#).

Table 67. ADC characteristics

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
$V_{DDA}$	Power supply	-	1.8 <sup>(1)</sup>	-	3.6	V
$V_{REF+}$	Positive reference voltage	-	1.8 <sup>(1)(2)(3)</sup>	-	$V_{DDA}$	
$V_{REF-}$	Negative reference voltage	-	-	0	-	
$f_{ADC}$	ADC clock frequency	$V_{DDA} = 1.8^{(1)(3)}$ to 2.4 V	0.6	15	18	MHz
		$V_{DDA} = 2.4$ to 3.6 V <sup>(3)</sup>	0.6	30	36	MHz
$f_{TRIG}^{(4)}$	External trigger frequency	$f_{ADC} = 30$ MHz, 12-bit resolution	-	-	1764	kHz
		-	-	-	17	1/ $f_{ADC}$
$V_{AIN}$	Conversion voltage range <sup>(5)</sup>	-	0 ( $V_{SSA}$ or $V_{REF-}$ tied to ground)	-	$V_{REF+}$	V
$R_{AIN}^{(4)}$	External input impedance	See <a href="#">Equation 1</a> for details	-	-	50	k $\Omega$
$R_{ADC}^{(4)(6)}$	Sampling switch resistance	-	-	-	6	k $\Omega$
$C_{ADC}^{(4)}$	Internal sample and hold capacitor	-	-	4	-	pF

**Figure 54. Asynchronous non-multiplexed SRAM/PSRAM/NOR read waveforms**

1. Mode 2/B, C and D only. In Mode 1, FSMC\_NADV is not used.

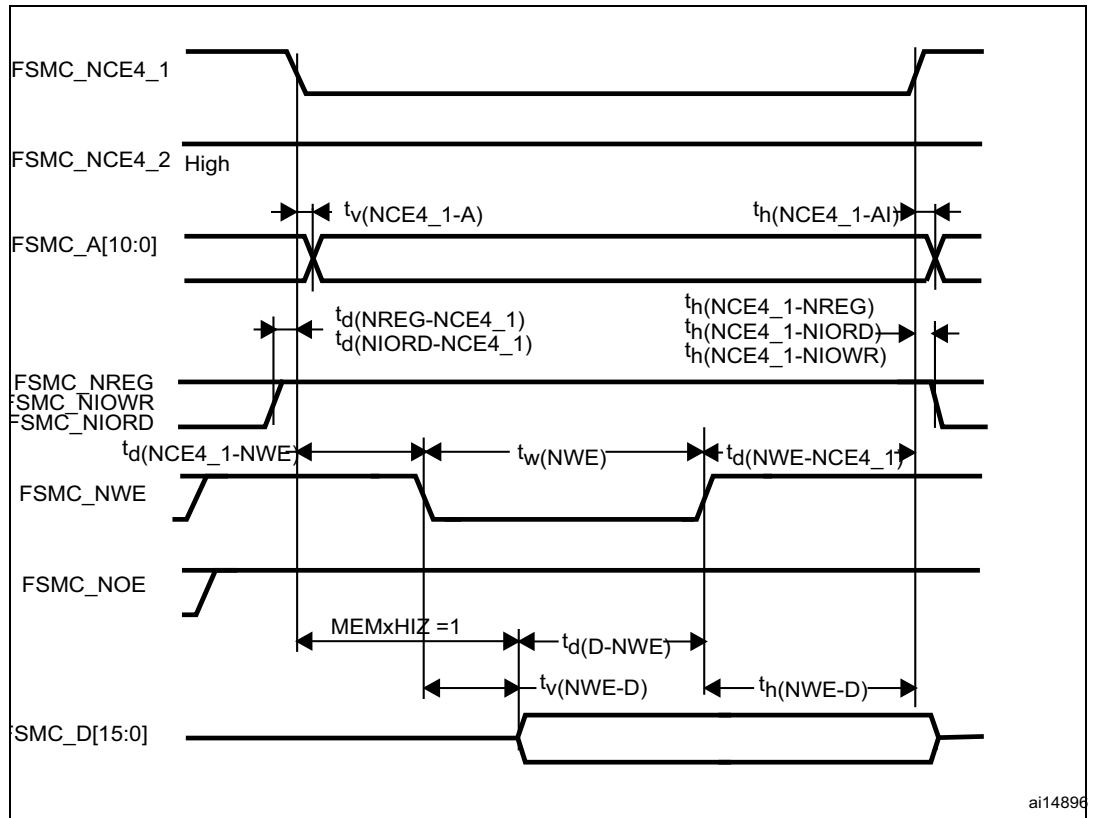
**Table 75. Asynchronous non-multiplexed SRAM/PSRAM/NOR read timings<sup>(1)(2)</sup>**

Symbol	Parameter	Min	Max	Unit
$t_{w(NE)}$	FSMC_NE low time	$2T_{HCLK}-0.5$	$2T_{HCLK}+1$	ns
$t_{v(NOE\_NE)}$	FSMC_NEx low to FSMC_NOE low	0.5	3	ns
$t_{w(NOE)}$	FSMC_NOE low time	$2T_{HCLK}-2$	$2T_{HCLK}+2$	ns
$t_{h(NE\_NOE)}$	FSMC_NOE high to FSMC_NE high hold time	0	-	ns
$t_{v(A\_NE)}$	FSMC_NEx low to FSMC_A valid	-	4.5	ns
$t_{h(A\_NOE)}$	Address hold time after FSMC_NOE high	4	-	ns
$t_{v(BL\_NE)}$	FSMC_NEx low to FSMC_NBL valid	-	1.5	ns
$t_{h(BL\_NOE)}$	FSMC_NBL hold time after FSMC_NOE high	0	-	ns
$t_{su(Data\_NE)}$	Data to FSMC_NEx high setup time	$T_{HCLK}+4$	-	ns
$t_{su(Data\_NOE)}$	Data to FSMC_NOEx high setup time	$T_{HCLK}+4$	-	ns
$t_{h(Data\_NOE)}$	Data hold time after FSMC_NOE high	0	-	ns
$t_{h(Data\_NE)}$	Data hold time after FSMC_NEx high	0	-	ns
$t_{v(NADV\_NE)}$	FSMC_NEx low to FSMC_NADV low	-	2	ns
$t_{w(NADV)}$	FSMC_NADV low time	-	$T_{HCLK}$	ns

1.  $C_L = 30$  pF.

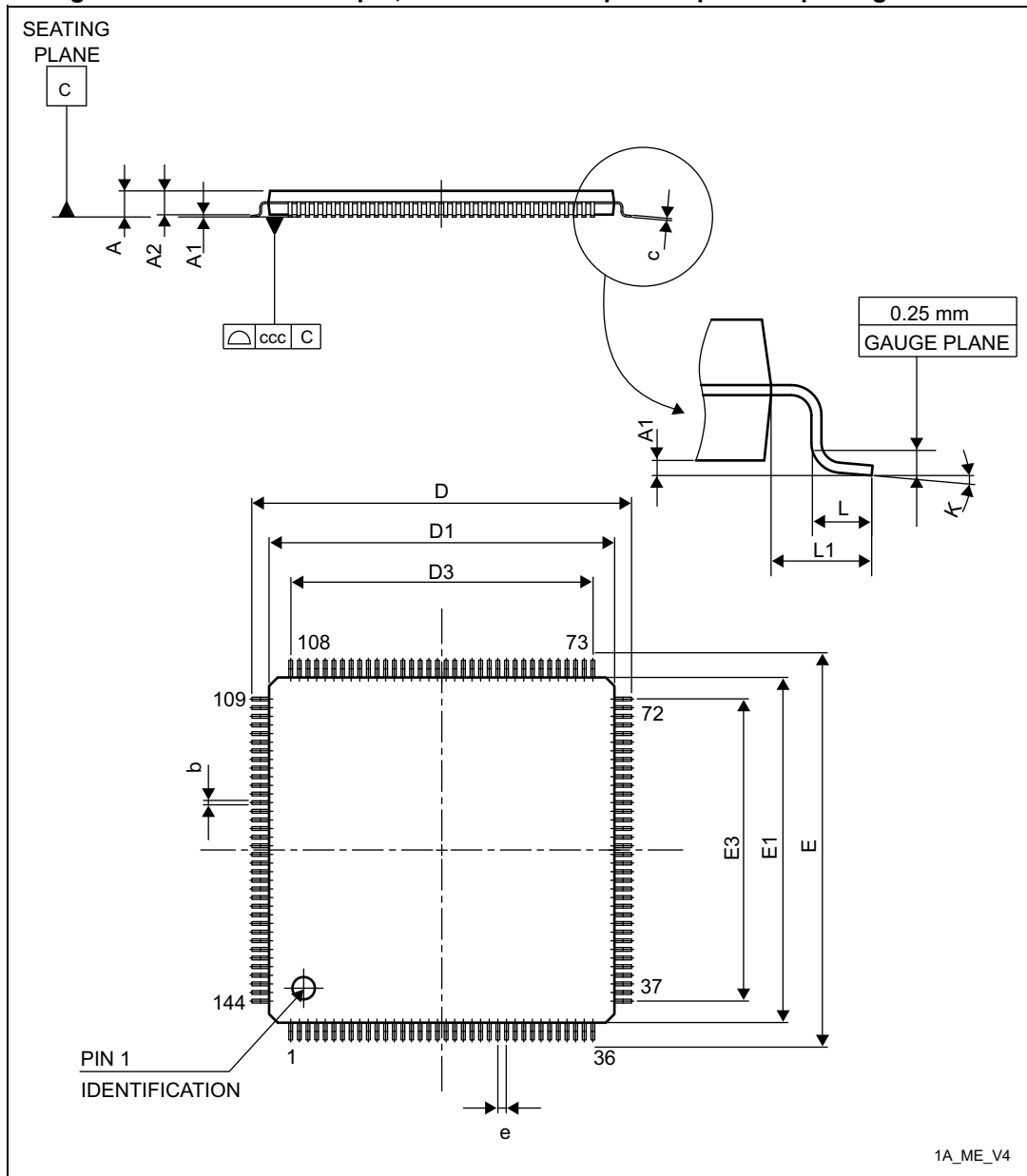
2. Guaranteed by characterization.

**Figure 63. PC Card/CompactFlash controller waveforms for common memory write access**



## 6.4 LQFP144 package information

**Figure 84. LQFP144 - 144-pin, 20 x 20 mm low-profile quad flat package outline**



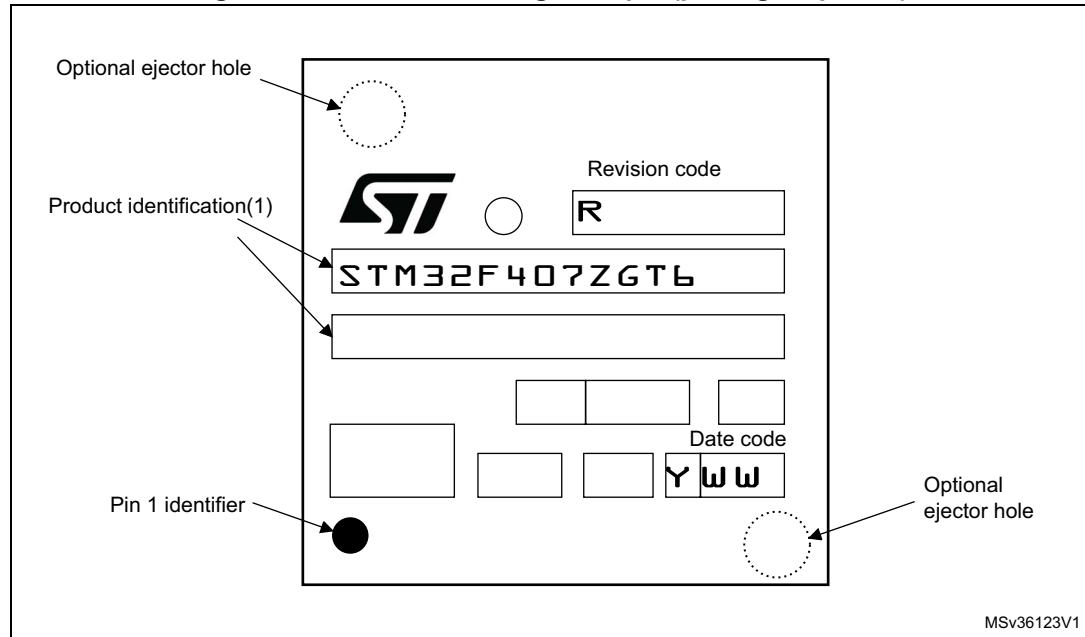
1. Drawing is not to scale.

### Device marking for LQFP144

The following figure gives an example of topside marking and pin 1 position identifier location.

Other optional marking or inset/upset marks, which depend on supply chain operations, are not indicated below.

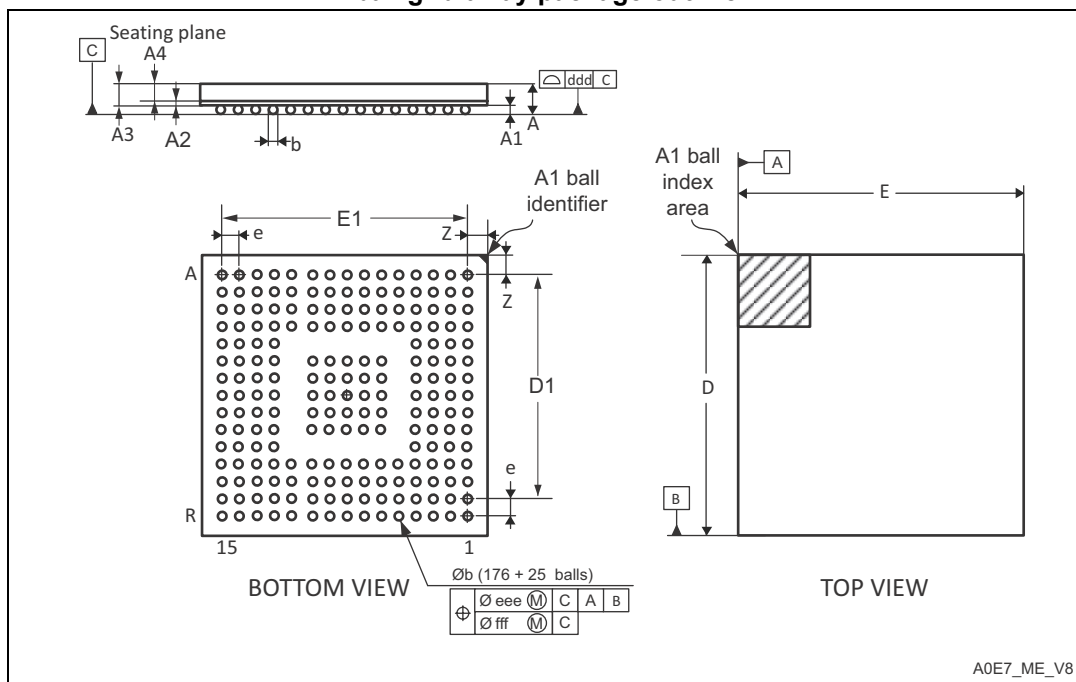
**Figure 86. LQFP144 marking example (package top view)**



1. Parts marked as "ES", "E" or accompanied by an Engineering Sample notification letter, are not yet qualified and therefore not yet ready to be used in production and any consequences deriving from such usage will not be at ST charge. In no event, ST will be liable for any customer usage of these engineering samples in production. ST Quality has to be contacted prior to any decision to use these Engineering Samples to run qualification activity.

## 6.5 UFBGA176+25 package information

Figure 87. UFBGA176+25 ball, 10 x 10 mm, 0.65 mm pitch, ultra fine pitch ball grid array package outline



1. Drawing is not to scale.

Table 95. UFBGA176+25 ball, 10 × 10 × 0.65 mm pitch, ultra thin fine pitch ball grid array mechanical data

Symbol	millimeters			inches <sup>(1)</sup>		
	Min	Typ	Max	Min	Typ	Max
A	-	-	0.600	-	-	0.0236
A1	-	-	0.110	-	-	0.0043
A2	-	0.130	-	-	0.0051	-
A3	-	0.450	-	-	0.0177	-
A4	-	0.320	-	-	0.0126	-
b	0.240	0.290	0.340	0.0094	0.0114	0.0134
D	9.850	10.000	10.150	0.3878	0.3937	0.3996
D1	-	9.100	-	-	0.3583	-
E	9.850	10.000	10.150	0.3878	0.3937	0.3996
E1	-	9.100	-	-	0.3583	-
e	-	0.650	-	-	0.0256	-
Z	-	0.450	-	-	0.0177	-
ddd	-	-	0.080	-	-	0.0031

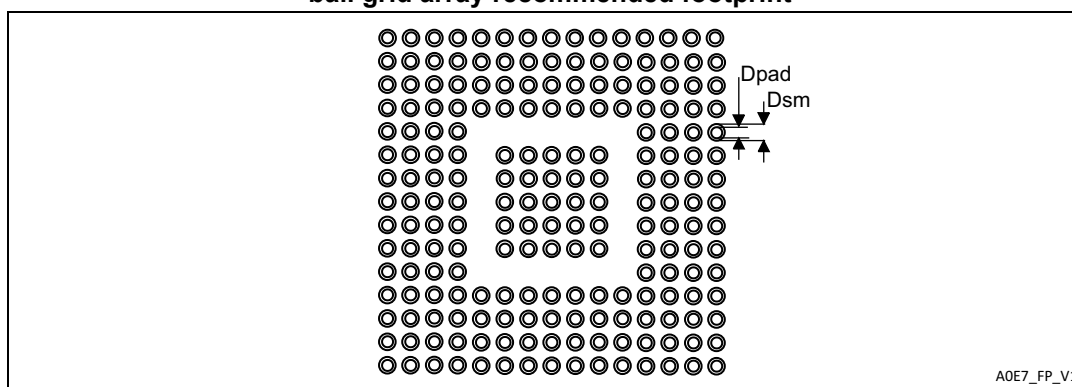


**Table 95. UFBGA176+25 ball, 10 × 10 × 0.65 mm pitch, ultra thin fine pitch ball grid array mechanical data (continued)**

Symbol	millimeters			inches <sup>(1)</sup>		
	Min	Typ	Max	Min	Typ	Max
eee	-	-	0.150	-	-	0.0059
fff	-	-	0.050	-	-	0.0020

1. Values in inches are converted from mm and rounded to 4 decimal digits.

**Figure 88. UFBGA176+25 - 201-ball, 10 x 10 mm, 0.65 mm pitch, ultra fine pitch ball grid array recommended footprint**



**Table 96. UFBGA176+2 recommended PCB design rules (0.65 mm pitch BGA)**

Dimension	Recommended values
Pitch	0.65
Dpad	0.300 mm
Dsm	0.400 mm typ. (depends on the soldermask registration tolerance)

**Note:** *Non solder mask defined (NSMD) pads are recommended.  
4 to 6 mils solder paste screen printing process.  
Stencil opening is 0.300 mm.  
Stencil thickness is between 0.100 mm and 0.125 mm.  
Pad trace width is 0.100 mm.*

## 6.7 Thermal characteristics

The maximum chip-junction temperature,  $T_J \text{ max}$ , in degrees Celsius, may be calculated using the following equation:

$$T_J \text{ max} = T_A \text{ max} + (P_D \text{ max} \times \Theta_{JA})$$

Where:

- $T_A \text{ max}$  is the maximum ambient temperature in °C,
- $\Theta_{JA}$  is the package junction-to-ambient thermal resistance, in °C/W,
- $P_D \text{ max}$  is the sum of  $P_{INT} \text{ max}$  and  $P_{I/O} \text{ max}$  ( $P_D \text{ max} = P_{INT} \text{ max} + P_{I/O} \text{ max}$ ),
- $P_{INT} \text{ max}$  is the product of  $I_{DD}$  and  $V_{DD}$ , expressed in Watts. This is the maximum chip internal power.

$P_{I/O} \text{ max}$  represents the maximum power dissipation on output pins where:

$$P_{I/O} \text{ max} = \Sigma (V_{OL} \times I_{OL}) + \Sigma (V_{DD} - V_{OH}) \times I_{OH},$$

taking into account the actual  $V_{OL} / I_{OL}$  and  $V_{OH} / I_{OH}$  of the I/Os at low and high level in the application.

**Table 98. Package thermal characteristics**

Symbol	Parameter	Value	Unit
$\Theta_{JA}$	Thermal resistance junction-ambient LQFP64 - 10 × 10 mm / 0.5 mm pitch	46	°C/W
	Thermal resistance junction-ambient LQFP100 - 14 × 14 mm / 0.5 mm pitch	43	
	Thermal resistance junction-ambient LQFP144 - 20 × 20 mm / 0.5 mm pitch	40	
	Thermal resistance junction-ambient LQFP176 - 24 × 24 mm / 0.5 mm pitch	38	
	Thermal resistance junction-ambient UFBGA176 - 10 × 10 mm / 0.65 mm pitch	39	
	Thermal resistance junction-ambient WLCSP90 - 0.400 mm pitch	38.1	

### Reference document

JESD51-2 Integrated Circuits Thermal Test Method Environment Conditions - Natural Convection (Still Air). Available from [www.jedec.org](http://www.jedec.org).

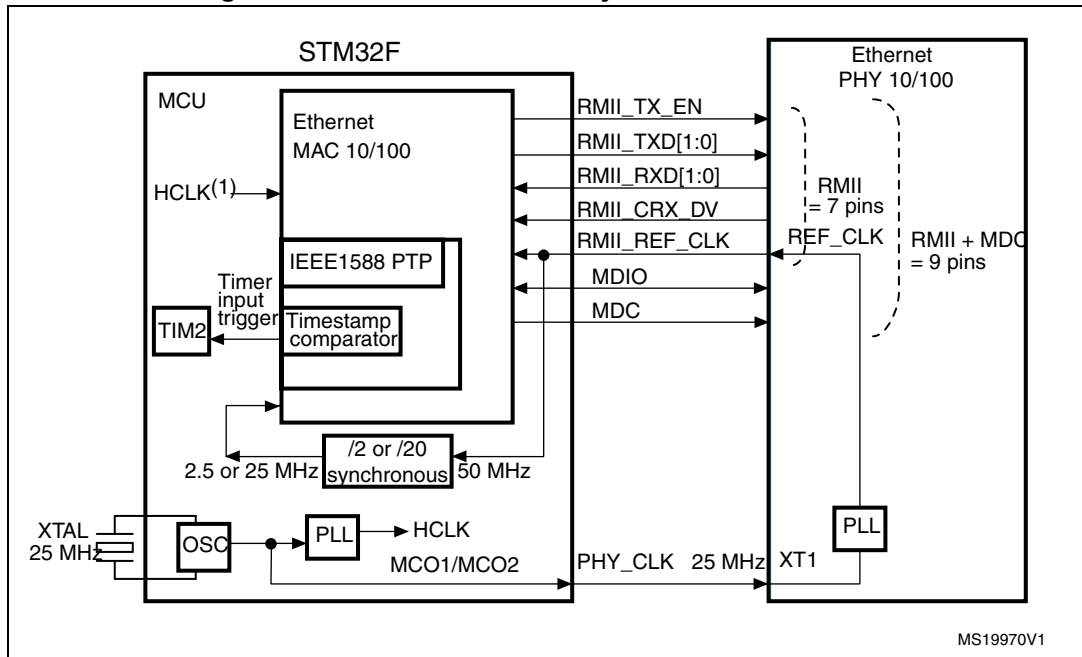
## 7 Part numbering

**Table 99. Ordering information scheme**

Example:	STM32	F	405	R	E	T	6	xxx
<b>Device family</b>								
STM32 = ARM-based 32-bit microcontroller								
<b>Product type</b>								
F = general-purpose								
<b>Device subfamily</b>								
405 = STM32F40xxx, connectivity								
407 = STM32F40xxx, connectivity, camera interface, Ethernet								
<b>Pin count</b>								
R = 64 pins								
O = 90 pins								
V = 100 pins								
Z = 144 pins								
I = 176 pins								
<b>Flash memory size</b>								
E = 512 Kbytes of Flash memory								
G = 1024 Kbytes of Flash memory								
<b>Package</b>								
T = LQFP								
H = UFBGA								
Y = WLCSP								
<b>Temperature range</b>								
6 = Industrial temperature range, –40 to 85 °C.								
7 = Industrial temperature range, –40 to 105 °C.								
<b>Options</b>								
xxx = programmed parts								
TR = tape and reel								

For a list of available options (speed, package, etc.) or for further information on any aspect of this device, please contact your nearest ST sales office.

**Figure 99. RMII with a 25 MHz crystal and PHY with PLL**



1.  $f_{HCLK}$  must be greater than 25 MHz.
2. The 25 MHz (PHY\_CLK) must be derived directly from the HSE oscillator, before the PLL block.

Table 100. Document revision history (continued)

Date	Revision	Changes
22-Oct-2015	6	<p>In the whole document, updated notes related to values guaranteed by design or by characterization.</p> <p>Updated <a href="#">Table 34: HSI oscillator characteristics</a>.</p> <p>Changed <math>f_{VCO\_OUT}</math> minimum value and VCO freq to 100 MHz in <a href="#">Table 36: Main PLL characteristics</a> and <a href="#">Table 37: PLLI2S (audio PLL) characteristics</a>.</p> <p>Updated <a href="#">Figure 39: SPI timing diagram - slave mode and CPHA = 0</a>.</p> <p>Updated <a href="#">Figure 53: 12-bit buffered /non-buffered DAC</a>.</p> <p>Removed note 1 related to better performance using a restricted <math>V_{DD}</math> range in <a href="#">Table 68: ADC accuracy at <math>f_{ADC} = 30</math> MHz</a>.</p> <p>Updated <a href="#">Figure 84: LQFP144 - 144-pin, 20 x 20 mm low-profile quad flat package outline</a>.</p> <p>Updated <a href="#">Figure 87: UFBGA176+25 ball, 10 x 10 mm, 0.65 mm pitch, ultra fine pitch ball grid array package outline</a> and <a href="#">Table 95: UFBGA176+25 ball, 10 x 10 x 0.65 mm pitch, ultra thin fine pitch ball grid array mechanical data</a>.</p>
16-Mar-2016	7	<p>Updated <a href="#">Figure 2: Compatible board design STM32F10xx/STM32F2/STM32F40xxx for LQFP100 package</a>.</p> <p>Updated <math> V_{SSX}-V_{SS} </math> in <a href="#">Table 11: Voltage characteristics</a> to add <math>V_{REF\_A}</math>.</p> <p>Added <math>V_{REF\_in}</math> in <a href="#">Table 67: ADC characteristics</a>.</p> <p>Updated <a href="#">Table 90: WLCSP90 - 4.223 x 3.969 mm, 0.400 mm pitch wafer level chip scale package mechanical data</a>.</p>
09-Sep-2016	8	<p>Remove note 1 below <a href="#">Figure 5: STM32F40xxx block diagram</a>.</p> <p>Updated definition of stresses above maximum ratings in <a href="#">Section 5.2: Absolute maximum ratings</a>.</p> <p>Updated <math>t_{h(NSS)}</math> in <a href="#">Figure 39: SPI timing diagram - slave mode and CPHA = 0</a> and <a href="#">Figure 40: SPI timing diagram - slave mode and CPHA = 1</a>.</p> <p>Added note related to optional marking and inset/upset marks in all package marking sections.</p> <p>Updated <a href="#">Figure 87: UFBGA176+25 ball, 10 x 10 mm, 0.65 mm pitch, ultra fine pitch ball grid array package outline</a> and <a href="#">Table 95: UFBGA176+25 ball, 10 x 10 x 0.65 mm pitch, ultra thin fine pitch ball grid array mechanical data</a>.</p>